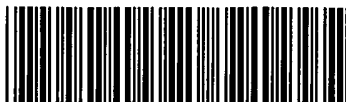


Search Notes

Application/Control No.

10/613,768

Examiner

J. Derek Rutten

Applicant(s)/Patent under
Reexamination

MCKINLAY ET AL.

Art Unit

2192

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Eric Kiss (consulted re. 112 and prior art)	10/13/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	10/13/2006	JDR
717/178 Text search only See search history printout	10/13/2006	JDR